

Diode Current Equation.

①

Going to derive: $I_D = I_0 (e^{V_D/V_T} - 1)$

Prerequisites

How PN junction behaves
Diffusion mechanism.

Derived:

1) $V_0 = V_T \ln \left[\frac{N_A N_D}{n_i^2} \right]$

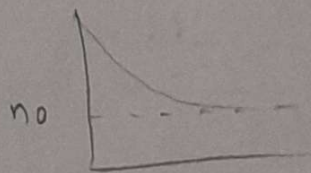
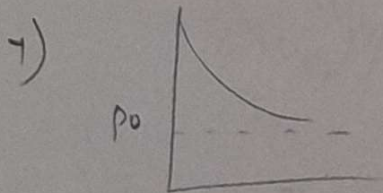
2) $P_p = P_n e^{V_0/V_T}$

3) $n_n = n_p e^{V_0/V_T}$

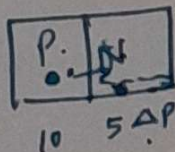
4) $P(-x_{p0}) = P_n e^{V_0/V_T}$

5) $n(x_{n0}) = n_p e^{V_0/V_T}$

6) PN junction at equilibrium will not have any current flow.



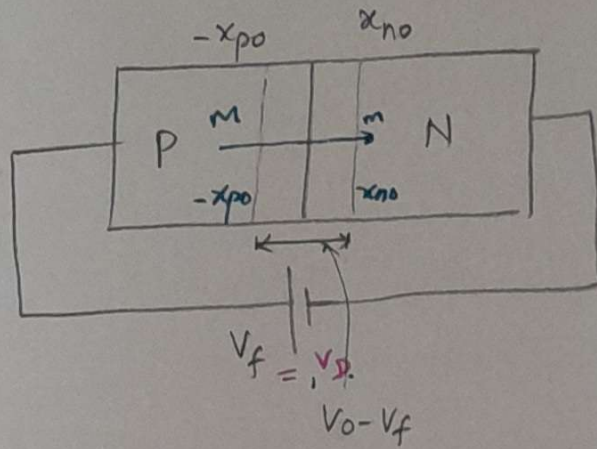
→ low level injection
minority carrier \ll majority carrier



Diode Current Equation

PN Jn in forward bias

[Lect



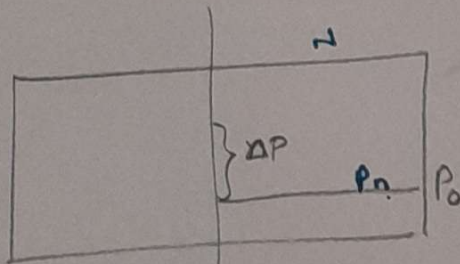
When forward bias is applied. - Depletion layer is small

- 1) holes diffuse into n-region
- 2) After reaching n-region they become minority carriers.
- 3) Now, it is similar to that of low level injection
 - Extra minority carriers are generated in N-type semiconductor

- follow exponential decay distribution.

[Formula]

from $P_p = P_n e^{V_0/V_T}$
under equilibrium.



$$P = \Delta P + P_n$$

$$P(-x_{p0}) = P_n e^{V_B/V_T}$$

$$P(-x_{p0}) = P(x_{n0}) \cdot e^{\frac{V_B - V_D}{V_T}}$$

$$1 = \frac{P_n}{P(x_{n0})} \cdot e^{V_D/V_T}$$

$$\Rightarrow P(x_{n0}) = P_n e^{\frac{V_D}{V_T}} \quad \text{--- (3)}$$

holes in N-regim.
 $\Rightarrow P = \Delta P + P_n$
applied voltage V_0

holes after diffusing into N-type SC they become minority carriers and follow an exponential decay.

$$p(x_{no}) = \Delta p + p_n$$

$$\Delta p = p(x_{no}) - p_n$$

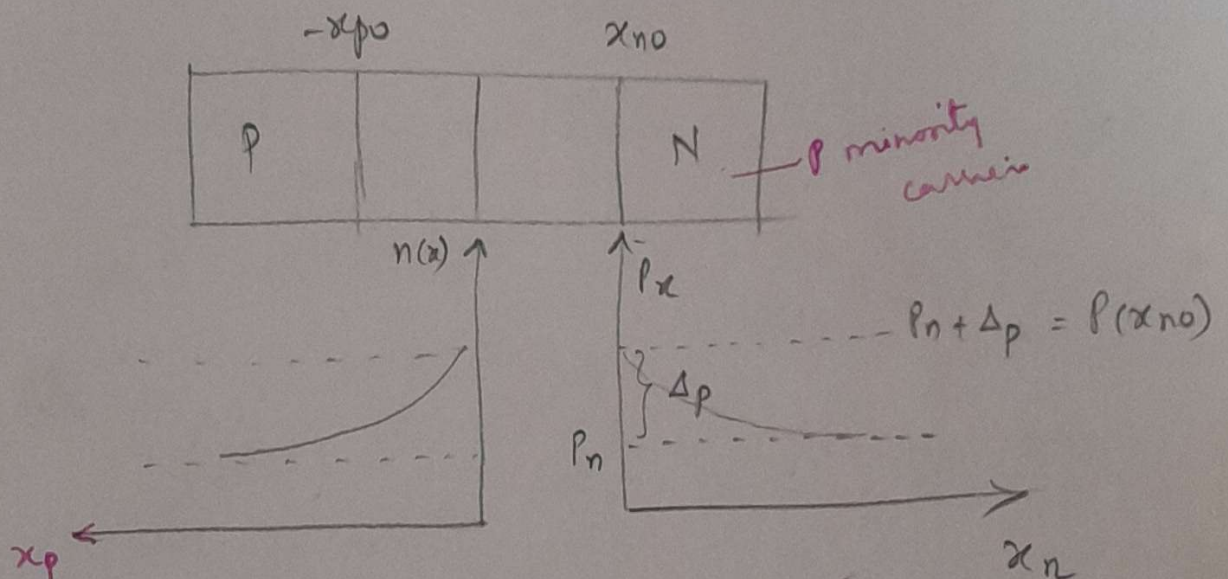
$$\Delta p = p_n e^{V_D/V_T} - p_n \quad [\text{From 3}]$$

$$\Delta p = p_n [e^{V_D/V_T} - 1] \quad \text{--- (4)}$$

So @ red
slope @ given

Similarly $\Delta n = N_p [e^{V_D/V_T} - 1] \quad \text{--- (5)}$

+
##



Distribution of minority carriers

~~$$\Delta n(x) \quad \delta_n(x) = \Delta p e^{-x/L_p}$$~~

diffusion length of holes

$$\sqrt{D_p \tau_p} = L_p$$

In N-type

$$\Delta p(x_n) \quad \delta_p(x_n) = \Delta p e^{-x_n/L_p} \quad \text{--- (6)}$$

$$\Delta n(x_p) \quad \delta_n(x_p) = \Delta n e^{-x_p/L_n} \quad \text{--- (7)}$$

Excess
e⁻ concentrations

Combining (4) and (6)

$$\Delta p(x_n) \delta p(x_n) = p_n (e^{V_D/V_T} - 1) \cdot e^{-x_n/L_p} \quad \text{--- (8)} \quad \#$$

$$\Delta n(x_p) \delta n(x_p) = N_p (e^{V_D/V_T} - 1) e^{-x_p/L_n} \quad \text{--- (9)}$$

The hole diffusion current density

$$J_p(x_n) = -q D_p \frac{dp}{dx}$$

$$= -q D_p \frac{d[\delta p(x_n)]}{dx_n} \quad \text{--- (10)}$$

excess hole distributions

The electron diffusion current density

$$J_n(x_p) = +q D_n \frac{d[\delta n(x_p)]}{dx_p} \quad \text{--- (11)}$$

$$\frac{d[\delta p(x_n)]}{dx_n} = p_n (e^{V_D/V_T} - 1) \left(-\frac{1}{L_p}\right) e^{-x_n/L_p} \quad \text{--- (12)}$$

Combining (10) and (12)

$$J_p(x_n) = \frac{+q D_p p_n (e^{+V_D/V_T} - 1) e^{-x_n/L_p}}{L_p}$$

$$I_p(x_n) = \frac{q D_p p_n (e^{+V_D/V_T} - 1) \cdot e^{-x_n/L_p}}{L_p} \times A \quad \text{--- (13)}$$

$$J_n(x_p) = q D_n n_p \left(e^{V_D/V_T} - 1 \right) e^{-x_p/L_n} \quad (-1/L_n) \quad (3)$$

$$I_n(x_p) = -Aq \frac{D_n}{L_n} n_p \left(e^{V_D/V_T} - 1 \right) e^{-x_p/L_n} \quad (14)$$

$$I_p = Aq \frac{D_p}{L_p} p_n \left(e^{V_D/V_T} - 1 \right) e^{-x_n/L_p}$$

$$I_n = + Aq \frac{D_n}{L_n} n_p \left(e^{V_D/V_T} - 1 \right) e^{-x_p/L_n}$$

$$I = I_n + I_p$$

We need constant current

So, at $x_n = 0$; $x_p = 0$.

$$I_p = Aq \frac{D_p}{L_p} p_n \left(e^{V_D/V_T} - 1 \right)$$

$$I_n = Aq \frac{D_n}{L_n} n_p \left(e^{V_D/V_T} - 1 \right)$$

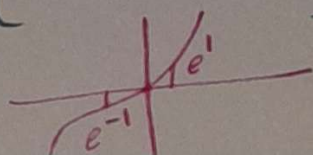
$$I = Aq \left(e^{V_D/V_T} - 1 \right) \left[\frac{D_p}{L_p} p_n + \frac{D_n}{L_n} n_p \right]$$

$$= I_s \left[e^{V_D/V_T} - 1 \right]$$

Where $I_0 = I_s = qA \left[\frac{D_p}{L_p} p_n + \frac{D_n}{L_n} n_p \right]$

$$= I_s \left[e^{\frac{V_D}{V_T}} - 1 \right]$$

When $V_D = \pm 1$



[minority carrier concentration]

$\leftarrow e^- \text{ movement}$
 $\rightarrow I_n$
 would be opposite to e^- flow.
 and that's why it is $-(e^- \text{ movement})$
 $-(-Aq \dots)$
 $= +Aq \frac{D_n}{L_n} \dots$